

# RF Power LDMOS Transistors

## N-Channel Enhancement-Mode Lateral MOSFETs

RF power transistors designed for applications operating at frequencies between 1200 and 1400 MHz, 1% to 12% duty cycle. These devices are suitable for use in pulse applications, such as L-Band radar.

- Typical Pulse Performance:  $V_{DD} = 50$  Vdc,  $I_{DQ} = 150$  mA,  $P_{out} = 330$  W Peak (39.6 W Avg.),  $f = 1400$  MHz, Pulse Width = 300  $\mu$ sec, Duty Cycle = 12%  
Power Gain — 18 dB  
Drain Efficiency — 60.5%
- Capable of Handling 5:1 VSWR @ 50 Vdc, 1400 MHz, 330 W Peak Power

### Features

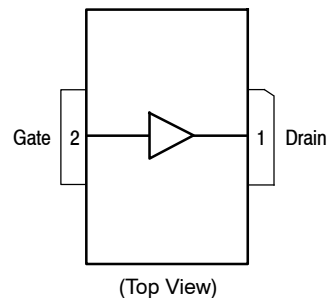
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Qualified Up to a Maximum of 50  $V_{DD}$  Operation
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- In Tape and Reel. R5 Suffix = 50 Units, 56 mm Tape Width, 13-inch Reel.

**MMRF1011HR5**  
**MMRF1011HSR5**

**1400 MHz, 330 W, 50 V**  
**PULSE L-BAND**  
**RF POWER MOSFETs**

**NI-780H-2L**  
**MMRF1011HR5**

**NI-780S-2L**  
**MMRF1011HSR5**



**Figure 1. Pin Connections**

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-0.5, +100	Vdc
Gate-Source Voltage	$V_{GS}$	-6.0, +10	Vdc
Storage Temperature Range	$T_{stg}$	-65 to +150	$^{\circ}$ C
Case Operating Temperature	$T_C$	150	$^{\circ}$ C
Operating Junction Temperature (1,2)	$T_J$	225	$^{\circ}$ C

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 65 $^{\circ}$ C, 330 W Peak, 300 $\mu$ sec Pulse Width, 12% Duty Cycle	$Z_{\theta JC}$	0.13	$^{\circ}$ C/W

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

**Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	1C
Machine Model (per EIA/JESD22-A115)	A
Charge Device Model (per JESD22-C101)	IV

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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**Off Characteristics**

Gate-Source Leakage Current ( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )	$I_{GSS}$	—	—	10	$\mu\text{Adc}$
Drain-Source Breakdown Voltage ( $V_{GS} = 0\text{ Vdc}$ , $I_D = 100\text{ mA}$ )	$V_{(BR)DSS}$	100	—	—	Vdc
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 50\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	50	$\mu\text{Adc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 90\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	2.5	mA

**On Characteristics**

Gate Threshold Voltage ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 662\ \mu\text{Adc}$ )	$V_{GS(th)}$	0.9	1.6	2.4	Vdc
Gate Quiescent Voltage ( $V_{DD} = 50\text{ Vdc}$ , $I_D = 150\text{ mA}$ , Measured in Functional Test)	$V_{GS(Q)}$	1.5	2.4	3	Vdc
Drain-Source On-Voltage ( $V_{GS} = 10\text{ Vdc}$ , $I_D = 1.63\text{ Adc}$ )	$V_{DS(on)}$	—	0.26	—	Vdc

**Dynamic Characteristics (1)**

Reverse Transfer Capacitance ( $V_{DS} = 50\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{rss}$	—	0.6	—	pF
Output Capacitance ( $V_{DS} = 50\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{oss}$	—	350	—	pF
Input Capacitance ( $V_{DS} = 50\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz)	$C_{iss}$	—	330	—	pF

**Functional Tests** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 50\text{ Vdc}$ ,  $I_{DQ} = 150\text{ mA}$ ,  $P_{out} = 330\text{ W Peak}$  (39.6 W Avg.),  $f = 1400\text{ MHz}$ , Pulsed, 300  $\mu\text{sec}$  Pulse Width, 12% Duty Cycle

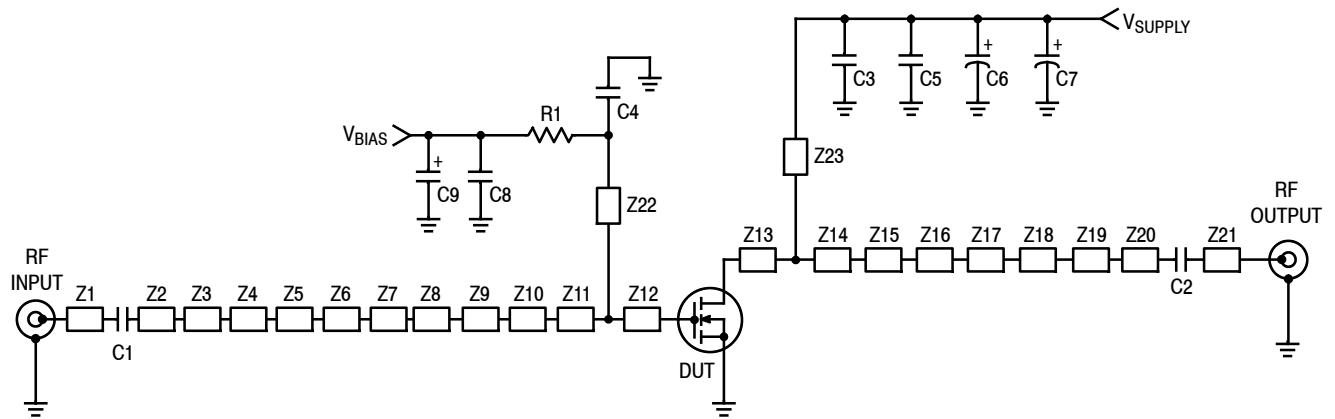
Power Gain	$G_{ps}$	16.5	18	19.5	dB
Drain Efficiency	$\eta_D$	59 <sup>(2)</sup>	60.5 <sup>(2)</sup>	—	%
Input Return Loss	IRL	—	-12	-9	dB

**Pulse RF Performance** (In Freescale Application Test Fixture, 50 ohm system)  $V_{DD} = 50\text{ Vdc}$ ,  $I_{DQ} = 150\text{ mA}$ ,  $P_{out} = 330\text{ W Peak}$  (39.6 W Avg.),  $f_1 = 1200\text{ MHz}$ ,  $f_2 = 1300\text{ MHz}$  and  $f_3 = 1400\text{ MHz}$ , 300  $\mu\text{sec}$  Pulse Width, 12% Duty Cycle,  $t_r = 50\text{ ns}$

Relative Insertion Phase	$ \Delta\Phi $	—	10	—	$^\circ$
Gain Flatness	$G_F$	—	0.5	—	dB
Pulse Amplitude Droop	$D_{rp}$	—	0.3	—	dB
Harmonic 2nd and 3rd	H2 & H3	—	-20	—	dBc
Spurious Response		—	-65	—	dBc
Load Mismatch Stability (VSWR = 3:1 at all Phase Angles)	VSWR-S	All Spurs Below -60 dBc			
Load Mismatch Tolerance (VSWR = 5:1 at all Phase Angles)	VSWR-T	No Degradation in Output Power			

1. Part internally matched both on input and output.

2. Drain efficiency is calculated by:  $\eta_D = \frac{100 \times P_{out}}{V_{DD} \times I_{peak}}$  where:  $I_{peak} = (I_{AVG} - I_{DQ}) / \text{Duty Cycle (\%)} + I_{DQ}$ .



Z1	0.205" x 0.080" Microstrip	Z13	0.110" x 0.866" Microstrip
Z2	0.721" x 0.022" Microstrip	Z14	0.630" x 0.866" Microstrip
Z3	0.080" x 0.104" Microstrip	Z15	0.307" x 0.470" Microstrip
Z4	0.128" x 0.022" Microstrip	Z16	0.045" x 0.221" Microstrip
Z5	0.062" x 0.134" Microstrip	Z17	0.171" x 0.136" Microstrip
Z6	0.440" x 0.022" Microstrip	Z18	0.120" x 0.430" Microstrip
Z7	0.262" x 0.496" Microstrip	Z19	0.964" x 0.136" Microstrip
Z8	0.030" x 0.138" Microstrip	Z20	0.177" x 0.078" Microstrip
Z9	0.256" x 0.028" Microstrip	Z21	0.215" x 0.078" Microstrip
Z10	0.058" x 0.254" Microstrip	Z22	1.577" x 0.070" Microstrip
Z11	0.344" x 0.087" Microstrip	Z23	1.459" x 0.070" Microstrip
Z12	0.110" x 0.087" Microstrip	PCB	Arlon CuClad 250GX-0300-55-22, 0.030", $\epsilon_r = 2.55$

**Figure 2. MMRF1011HR5(HSR5) Test Circuit Schematic**

**Table 5. MMRF1011HR5(HSR5) Test Circuit Component Designations and Values**

Part	Description	Part Number	Manufacturer
C1	43 pF Chip Capacitor	ATC100B430JT500XT	ATC
C2	18 pF Chip Capacitor	ATC100B180JT500XT	ATC
C3	33 pF Chip Capacitor	ATC100B330JT500XT	ATC
C4	27 pF Chip Capacitor	ATC100B270JT500XT	ATC
C5	2.2 $\mu$ F, 100 V Chip Capacitor	2225X7R225KT3AB	ATC
C6	470 $\mu$ F, 63 V Electrolytic Capacitor	EMVY630GTR471MMH0S	Multicomp
C7	330 pF, 63 V Electrolytic Capacitor	EMVY630GTR331MMH0S	Multicomp
C8	0.1 $\mu$ F, 35 V Chip Capacitor	CDR33BX104AKYS	Kemet
C9	10 $\mu$ F, 35 V Tantalum Capacitor	T491D106K035AT	Kemet
R1	10 $\Omega$ , 1/4 W Chip Resistor	CRCW120610R0FKEA	Vishay

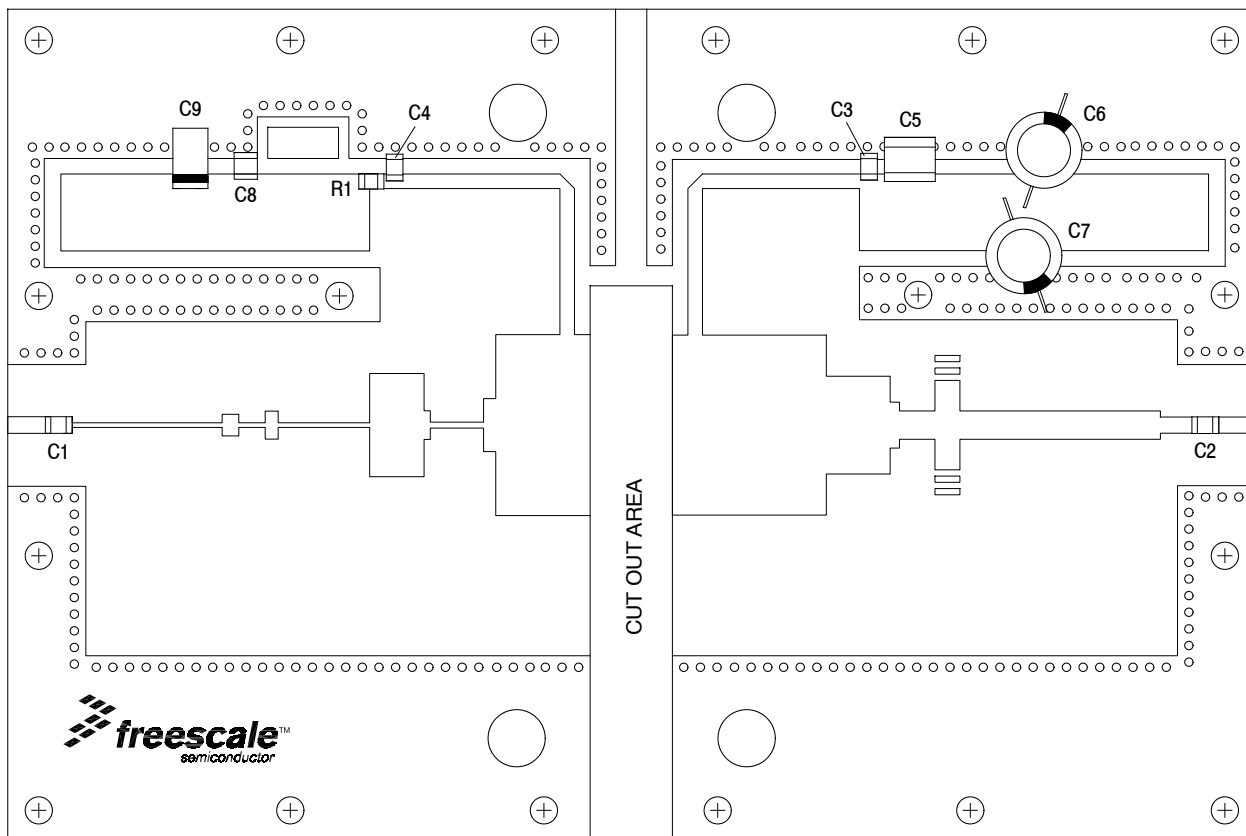


Figure 3. MMRF1011HR5(HSR5) Test Circuit Component Layout

## TYPICAL CHARACTERISTICS

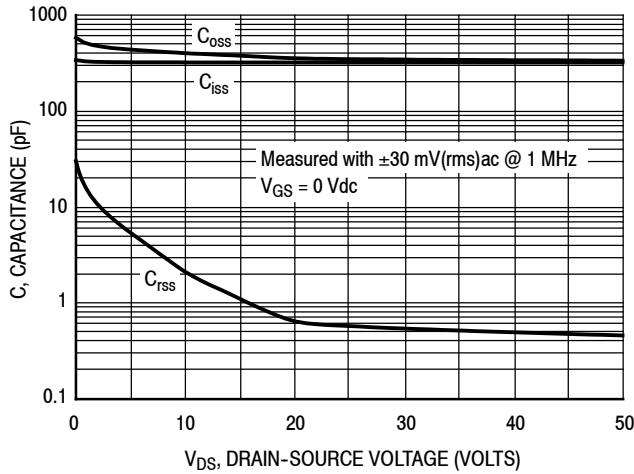


Figure 4. Capacitance versus Drain-Source Voltage

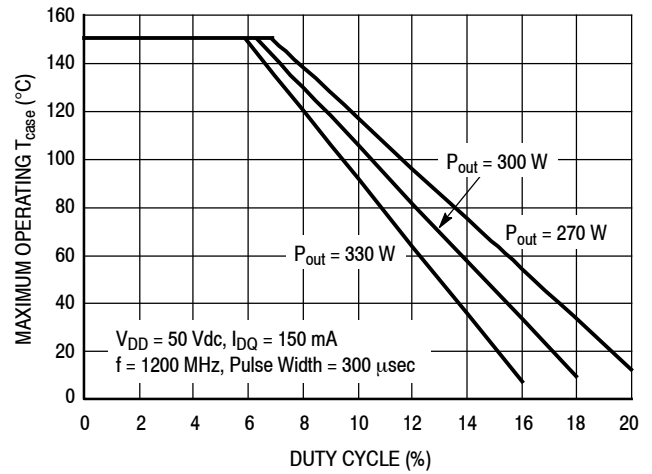


Figure 5. Safe Operating Area

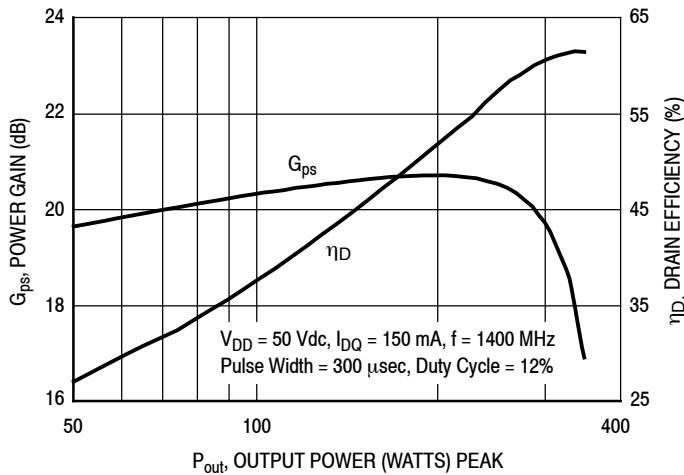


Figure 6. Power Gain and Drain Efficiency versus Output Power

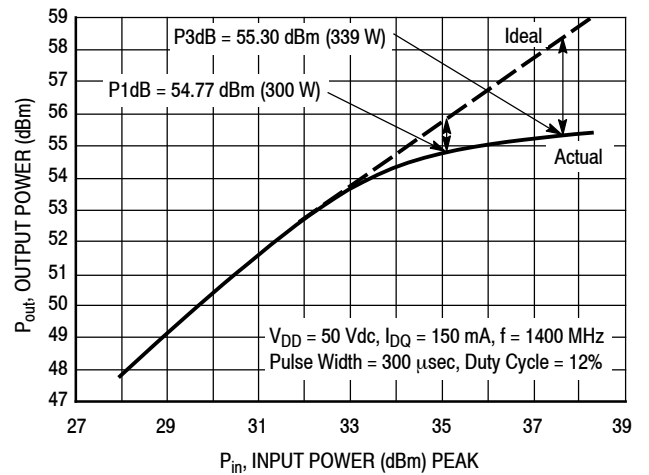


Figure 7. Output Power versus Input Power

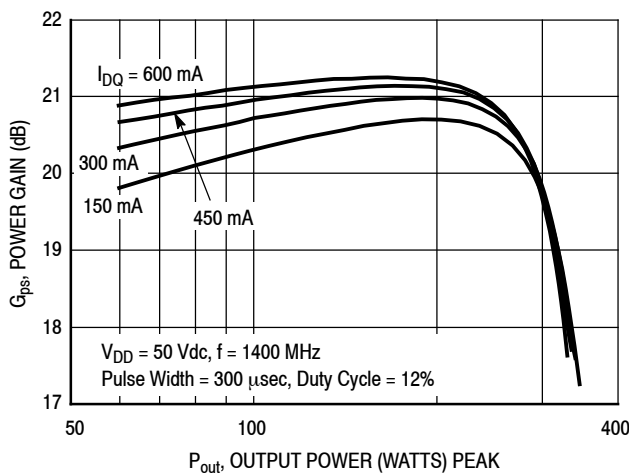


Figure 8. Power Gain versus Output Power

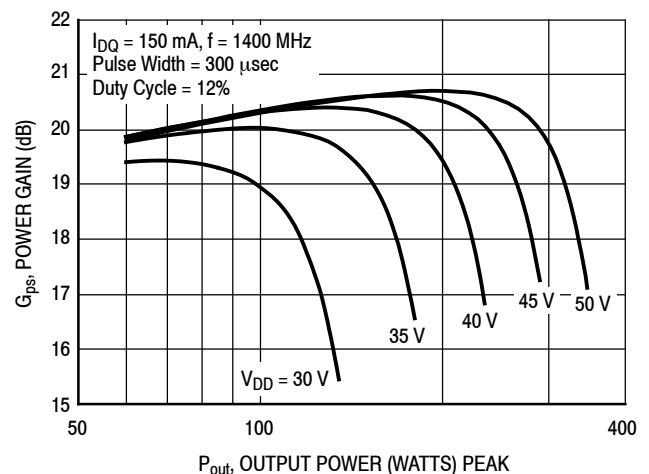


Figure 9. Power Gain versus Output Power

### TYPICAL CHARACTERISTICS

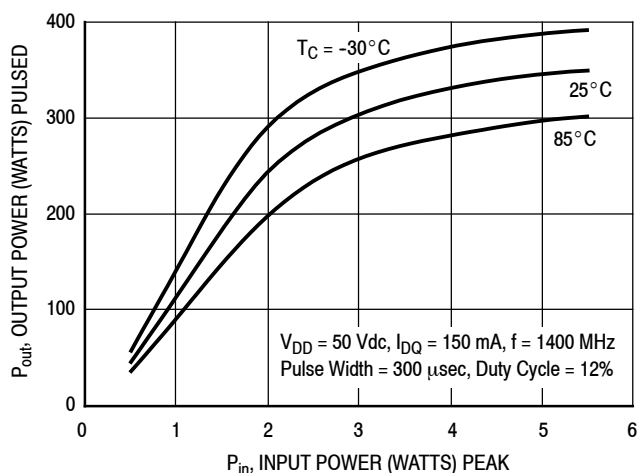


Figure 10. Output Power versus Input Power

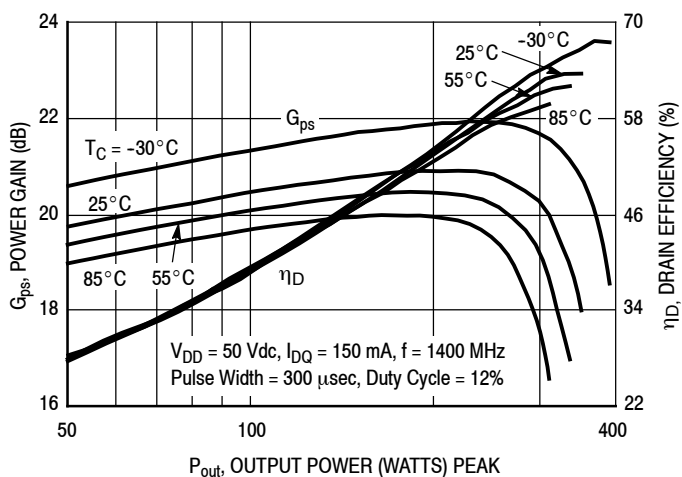


Figure 11. Power Gain and Drain Efficiency versus Output Power

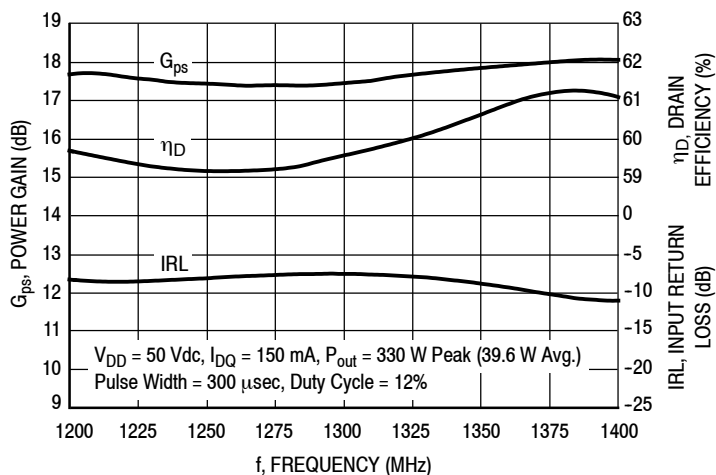
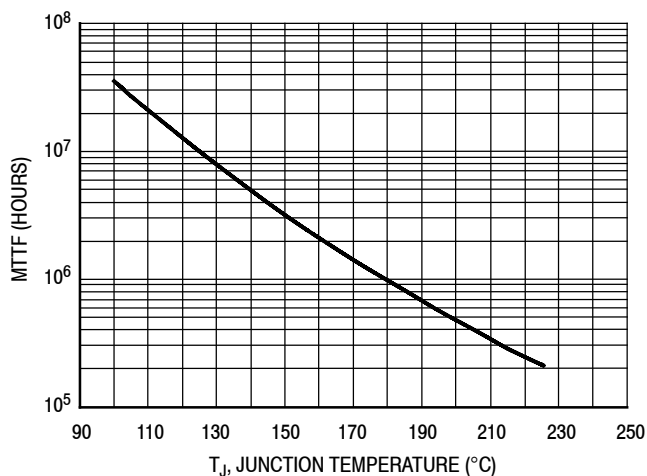


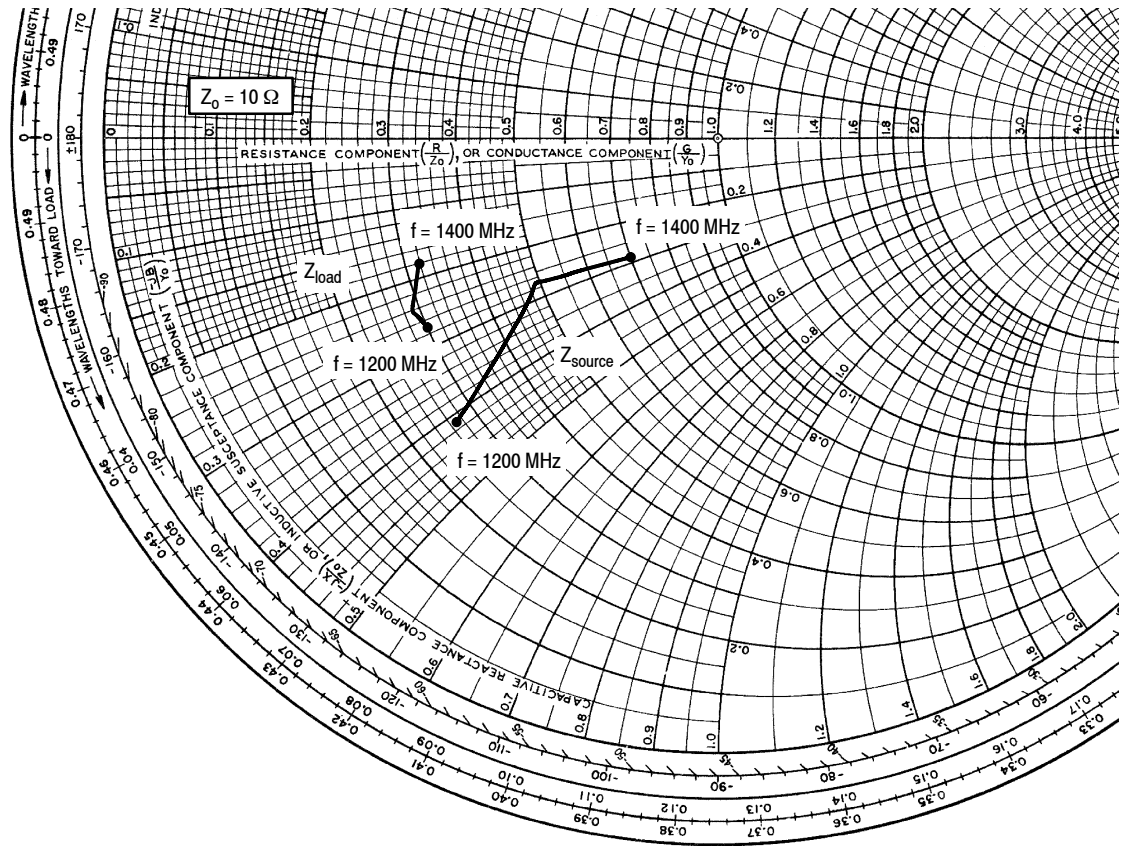
Figure 12. Broadband Performance @  $P_{out} = 330$  Watts Peak



This above graph displays calculated MTTF in hours when the device is operated at  $V_{DD} = 50$  Vdc,  $P_{out} = 330$  W Peak, Pulse Width = 300  $\mu$ sec, Duty Cycle = 12%, and  $\eta_D = 60.5\%$ .

MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

Figure 13. MTTF versus Junction Temperature



$V_{DD} = 50 \text{ Vdc}$ ,  $I_{DQ} = 150 \text{ mA}$ ,  $P_{out} = 330 \text{ W Peak}$

f MHz	$Z_{source}$ $\Omega$	$Z_{load}$ $\Omega$
1200	$2.70 - j4.10$	$2.97 - j2.66$
1300	$4.93 - j2.66$	$2.85 - j2.40$
1400	$7.01 - j2.87$	$3.17 - j1.78$

$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

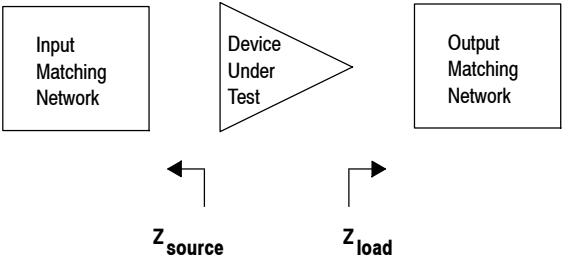
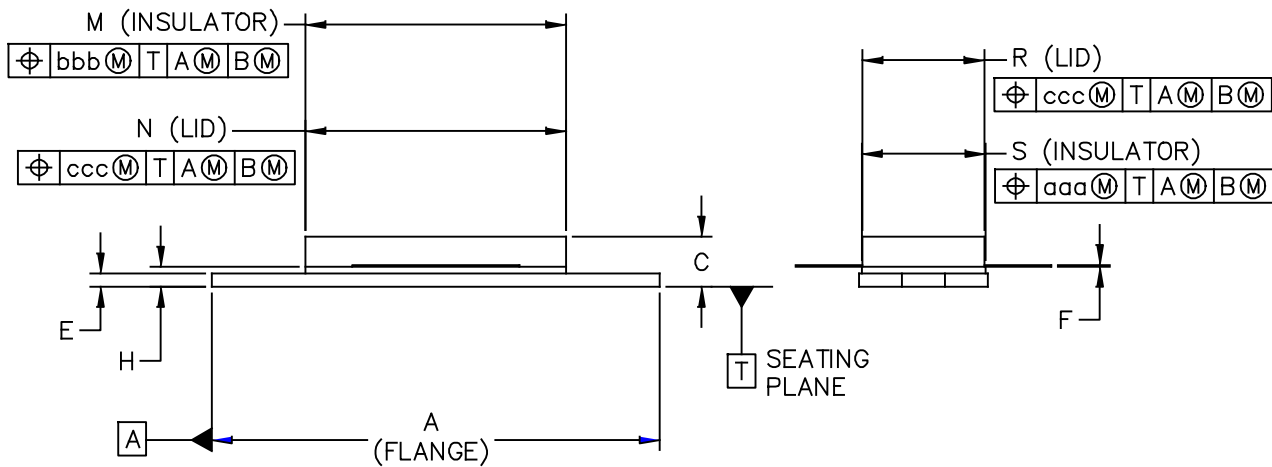
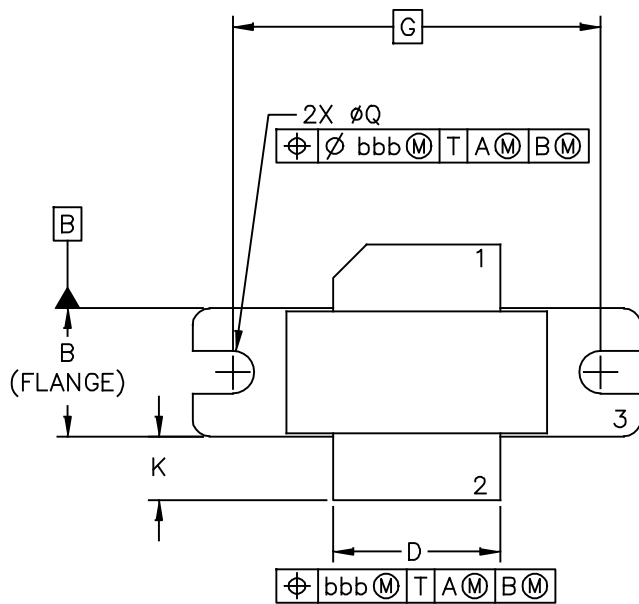


Figure 14. Series Equivalent Source and Load Impedance

### PACKAGE DIMENSIONS



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	CASE NUMBER: 465-06		31 MAR 2005
	STANDARD: NON-JEDEC		



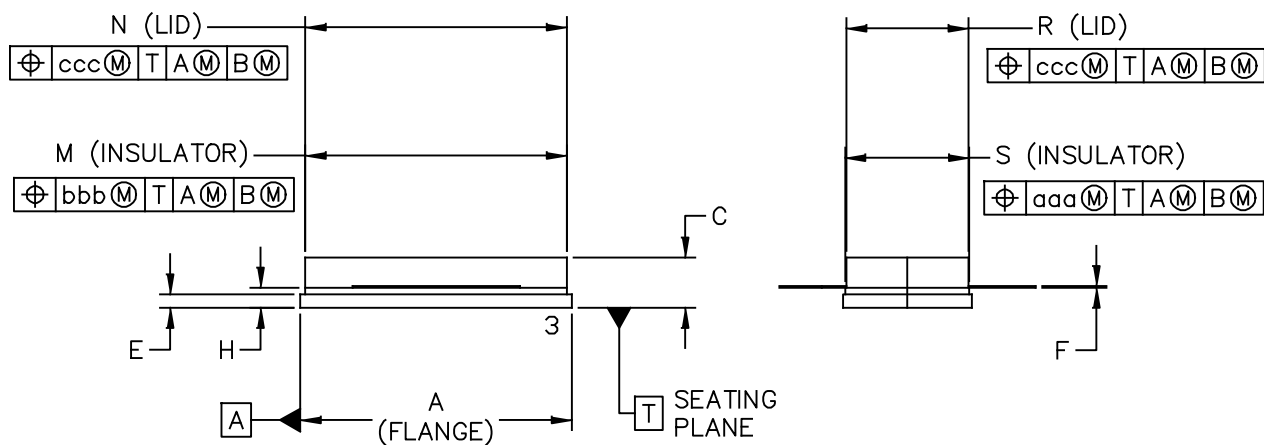
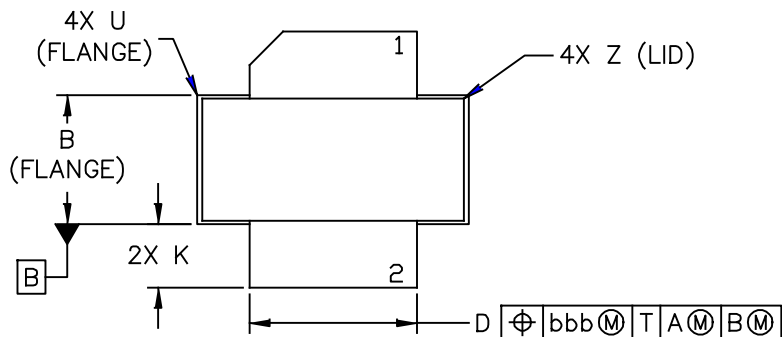
NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH.
3. DELETED
4. DIMENSION H IS MEASURED .030 (.762) AWAY FROM PACKAGE BODY.

STYLE 1:

- PIN
1. DRAIN
  2. GATE
  3. SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16	R	.365	.375	9.27	9.53
B	.380	.390	9.65	9.91	S	.365	.375	9.27	9.52
C	.125	.170	3.18	4.32	aaa	—	.005	—	0.127
D	.495	.505	12.57	12.83	bbb	—	.010	—	0.254
E	.035	.045	0.89	1.14	ccc	—	.015	—	0.381
F	.003	.006	0.08	0.15	—	—	—	—	—
G	1.100 BSC		27.94 BSC		—	—	—	—	—
H	.057	.067	1.45	1.7	—	—	—	—	—
K	.170	.210	4.32	5.33	—	—	—	—	—
M	.774	.786	19.66	19.96	—	—	—	—	—
N	.772	.788	19.6	20	—	—	—	—	—
Q	∅.118	∅.138	∅3	∅3.51	—	—	—	—	—
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3. DELETED
4. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.

STYLE 1:

- PIN 1. DRAIN
- 2. GATE
- 3. SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	.805	-.815	20.45	20.7	U	-.040	-	-	1.02
B	.380	-.390	9.65	9.91	Z	-.030	-	-	0.76
C	.125	-.170	3.18	4.32	aaa	-.005	-	-	0.127
D	.495	-.505	12.57	12.83	bbb	-.010	-	-	0.254
E	.035	-.045	0.89	1.14	ccc	-.015	-	-	0.381
F	.003	-.006	0.08	0.15	-	-	-	-	-
H	.057	-.067	1.45	1.7	-	-	-	-	-
K	.170	-.210	4.32	5.33	-	-	-	-	-
M	.774	-.786	19.61	20.02	-	-	-	-	-
N	.772	-.788	19.61	20.02	-	-	-	-	-
R	.365	-.375	9.27	9.53	-	-	-	-	-
S	.365	-.375	9.27	9.52	-	-	-	-	-

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TITLE:  NI-780S		DOCUMENT NO: 98ASB16718C		REV: H	
		CASE NUMBER: 465A-06		31 MAR 2005	
		STANDARD: NON-JEDEC			

## PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following resources to aid your design process.

### Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### Software

- Electromigration MTTF Calculator

For Software, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

## REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	July 2014	• Initial Release of Data Sheet

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